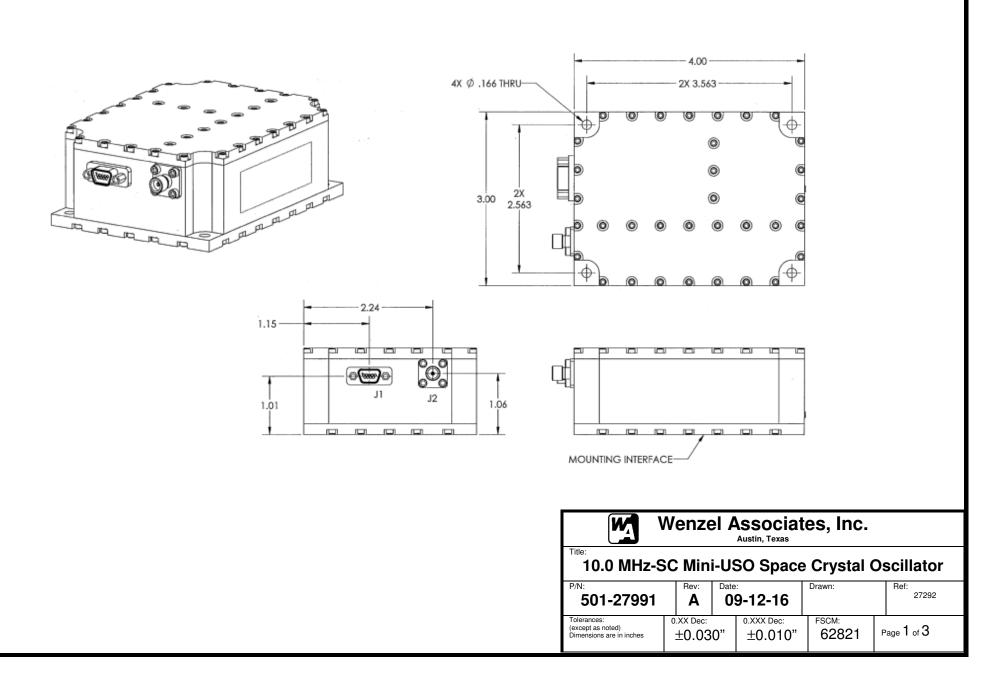
DATE	REVISION RECORD	DWN	AUTH
04-02-14	Initial Release	Liz	
09-12-16	Update 501-	Liz	
	04-02-14	04-02-14 Initial Release	04-02-14 Initial Release Liz



			REV	DATE	REVISION RECORD	DWN	AUTH	
GENERAL REQUIREMENTS		1	n E V				AUTH	
Material, Design and Construction	MIL-PRF-55310		Ā	04-02-14 09-12-16	Initial Release	Liz Liz		
Parts and Materials List Crystal	Supplied Premium Q, Z-swept, synthetic quartz, 1/10 output frequency		A	09-12-10	Update 501-	LIZ		
Outgassing	TML<1% and CVCM <0.1% per SP-R-002A							
Traceability	Semiconductor and passive lot and date code tracking							
De-rating	per EEE-INST-002, (JPL-D-8545, alternative)							
Soldering	J-STD-001 class 3	MODEL D	EFINITI	ONS				
Case Finish	Nickel-plated aluminum housing Electroless nickel per MIL-C-26074							
1 111011		PF (Proto	-Flight	Model)	Design and Construction similar in appearance	and ide	ntical in	
					form, fit, and function to FM. Developed using practice, including some commercial parts and			
					shall be subjected only to electrical tests, with		3. LIVI	
RF Output Frequency	10 MHz (fixed, please specify), sine wave ±1 x 10 ⁻⁸ at +25°C				environmental testing performed.			
Frequency Accuracy (initial)	$\pm 1 \times 10$ at $\pm 25^{\circ}$ C		M - 1 - 1	`	Estado da da constallada das constantinas en			
Frequency Stability Aging Rate (after 90 days operating)	<1x 10 ⁻⁹ over 3°C, -20°C to +60°C, under vacuum	FM (Flight Model) Fabricated to meet all design, construction, an requirements reference MIL-PRF-55310, Class		a test a 1 Produ	ict loval			
1 day	±2x 10 ⁻¹⁰				S. FM shall be subjected to the entire complim			
1 year	$\pm 2 \times 10^{-8}$ after 60 days operating				and environmental acceptance tests listed.			
RF Output Power	$\pm 2 \times 10^{-1}$ after 60 days operating +12 dBm ± 2 dB into 50Ω							
RF Output 2 nd Harmonic	-30 dBc				Flight Model Space Level, Parts EEE-INST-00 MIL-PRF-3098 Level 2 Crystals, Tested to Tal	2, Level	1,2,3 N Table 2	
RF Output Spurious	≤-100 dBc, 100 KHz to 1 GHz				by similarity			
Phase Noise (Static)	<u>10 MHz</u>				MIL-PRF-19500 / MIL-STD-750 Semiconducto			
1 Hz 10 Hz	-108 dBc/Hz -138 dBc/Hz				JANTXV with PIN D, JANTX with PIN D and D	PA (5 ea)	
100 Hz	-155 dBc/Hz	Qualificat	ion Moc		EM unit, when specified, using EEE-INST-002	1 امریم ا	2 3 narte	
1kHz	-161 dBc/Hz	Quanicat			where available. Testing for (1) unit.	, LOVOI I,	2,0 parts	
10kHz	-162 dBc/Hz				3 ()			
Allen Deviation (10 to 10kHz)	1 second 3e-12 10 seconds 3e-12							
	100 seconds 3e-12							
Supply voltage	+15 VDC ±5%	501-279	91-01		Proto-Flight Model			
Warm-up power	≤8 watts							
Warm-up time	≤ 20 minutes at ambient pressure $\leq 5 \times 10^{-5}$ torr	501-27991-02		2	Qualification Model			
Input power	≤5 watts steady state at ambient pressure ≤5 x 10 ⁻⁵ torr	501-27991-03		2	FM Flight Model			
ENVIRONMENTAL CONDITIONS		001 270		,	r wr nght woder			
Acceptance temperature	-20°C to +60°C							
Proto-flight temperature	-20°C to +60°C							
Storage temperature	-40°C to +85°C							
Ambient pressure	Atmospheric (760 torr), Vacuum (≤5 x 10 ⁻⁵ torr)							
MECHANICAL SPECIFICATIONS								
Size	4" x 3" x 1.5"							
Weight	≤380 grams							
Physical	Pressure relief holes, vented							
					Wenzel Associates, Inc.			
		Austin, Texas						
		Title:					_	
		10.0 MHz-SC Mini-USO Space Crystal Oscilla P/N: Rev: Date: Drawn: Ref:				Oscil	lator	
				501-279	91 A 09-12-16		27292	
				rances:	0.XX Dec: 0.XXX Dec: FSCM:			
			(exc	ept as noted) ensions are in inch		Page 2	2 of 3	
		I	Dille			9-	-	
			_					

QUALIFICATION TESTS (Non-flight model, only)

COALINGATION TEORO (Non high model, only)						
Group I (1 samples)	Visual, Electrical Tests*					
Burn-In (operational)	240 hours minimum at +75°C					
Group II (1 samples)						
Aging	30 Days					
Group III Subgroup 1 (1 sample)						
Random Vibration	11.95 Grms, MIL-STD-202, method 214 I-D,					
	50 to 2000 Hz, 5 min per axis					
Shock	MIL-STD-202, Method 213, Condition A, 50G, 11msec					
Group III Subgroup 2 (1 sample)						
Thermal Shock	MIL-STD-202, Method 107, Condition A-1,					
	25 cycles, -55°C to +85°C					
Ambient Pressure	MIL-STD-202, Method 105, at $<5 \times 10^{-5}$ torr					

Ambient Pressure Group III Subgroup 3 (1 sample) Resistance to Soldering Heat Group III Subgroup 4 (1 sample) Terminal Strength

Solderability Resistance to Solvents

Electrical Tests* Radiographics

ACCEPTANCE TESTS (Flight Model)

Electrical Tests* Random Vibration (non-operational) 7.56 Grms overall, MIL-STD-202 Method 214 Test Cond I-B,

Thermal Shock

Electrical Tests* Burn-In (operational) Aging Rate Electrical Tests* Radiographics

5 Cycles, -55°C to +85°C 240 hours minimum at +75°C Projected to 30 days operating

MIL-STD-202, Method 107, Condition A.

MIL-STD-202, Method 210, Condition A

MIL-STD-202, Method 211, Condition C,

Not applicable when marking is electro-etched

Not applicable for pins <0.25"

MIL-STD-202, Method 208

MIL-STD-202, Method 215

MIL-STD-202, method 209

50 to 2000 Hz. 5 min per axis

MIL-STD-202, method 209

*ELECTRICAL TESTS

Tested at ambient pressure $\leq 5 \times 10^{-5}$ torr and at -20, +25, and 60°C unless otherwise noted

Warm-Up Power (-20°C only) Warm-Up Time (-20°C only) Input Power Cold Start (-20°C) Hot Start (+60°C) RF Output Power RF Output Harmonics **RF** Output Spurious Frequency Accuracy (+25°C only) Frequency Stability Phase Noise - Static (+25°C only, 760 torr)

ANALYSES

Thermal Analysis, Component Stress Analysis

REV	DATE	REVISION RECORD	DWN	AUTH
-	04-02-14	Initial Release	Liz	
А	09-12-16	Update 501-	Liz	

Wenzel Associates, Inc. Austin, Texas Title: 10.0 MHz-SC Mini-USO Space Crystal Oscillator P/N: Drawn: Date: Rev: Ref: 27292 501-27991 Α 09-12-16 0.XXX Dec: Tolerances: 0.XX Dec: FSCM: (except as noted) Page 3 of 3 62821 ±0.030" ±0.010" Dimensions are in inches